

**N-Channel Enhancement Mode Power MOSFET**

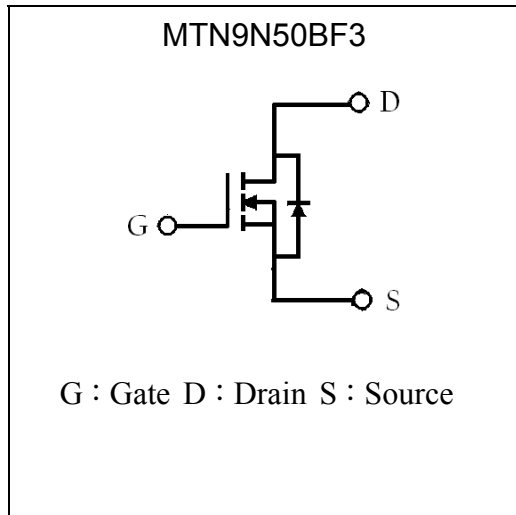
# MTN9N50BF3

BV <sub>DSS</sub>	500V
I <sub>D</sub> @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C	8.5A
I <sub>D</sub> @ V <sub>GS</sub> =10V, T <sub>C</sub> =100°C	5.4A
R <sub>DS(on)(TYP)</sub> @ V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A	0.71 Ω

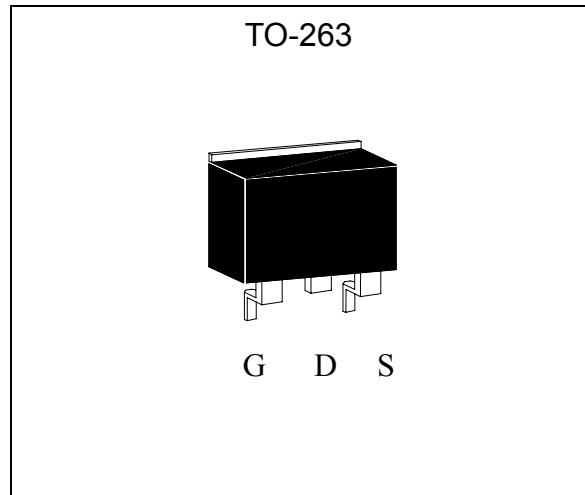
**Features**

- Low Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic
- RoHS compliant package

**Symbol**

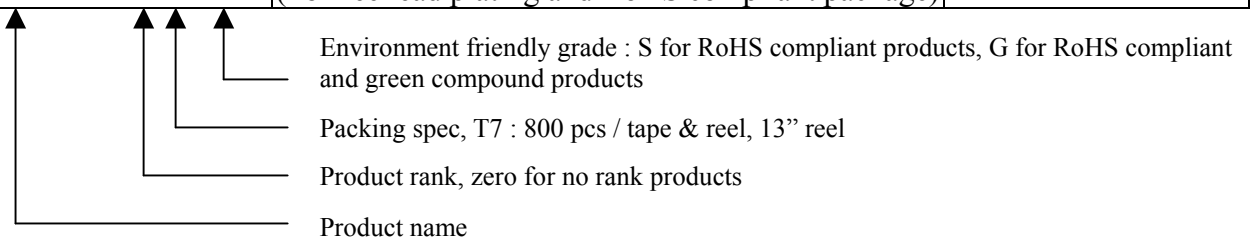


**Outline**



**Ordering Information**

Device	Package	Shipping
MTN9N50BF3-0-T7-X	TO-263 (Pb-free lead plating and RoHS compliant package)	800 pcs / Tape & Reel



**Absolute Maximum Ratings** ( $T_C=25^\circ\text{C}$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage (Note 1)	$V_{DS}$	500	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	
Continuous Drain Current @ $T_C=25^\circ\text{C}$ , $V_{GS}=10\text{V}$	$I_D$	8.5*	A
Continuous Drain Current @ $T_C=100^\circ\text{C}$ , $V_{GS}=10\text{V}$		5.4*	
Pulsed Drain Current @ $V_{GS}=10\text{V}$ (Note 2)	$I_{DM}$	34*	
Single Pulse Avalanche Energy (Note 3)	$E_{AS}$	290	mJ
Avalanche Current (Note 2)	$I_{AS}$	8	A
Repetitive Avalanche Energy (Note 2)	$E_{AR}$	12.5	mJ
Maximum Temperature for Soldering @ Lead at 0.125 in(3.175mm) from case for 10 seconds	$T_L$	300	$^\circ\text{C}$
Total Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	134	W
Linear Derating Factor above $25^\circ\text{C}$		1.07	W/ $^\circ\text{C}$
Operating Junction and Storage Temperature	$T_j, T_{stg}$	-55~+150	$^\circ\text{C}$

\*Drain current limited by maximum junction temperature

Note : 1.  $T_J=+25^\circ\text{C}$  to  $+150^\circ\text{C}$ .

2. Repetitive rating; pulse width limited by maximum junction temperature.

3.  $I_{AS}=8\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $L=5\text{mH}$ ,  $R_G=25\ \Omega$ , starting  $T_J=+25^\circ\text{C}$ . 100% tested by conditions of  $I_{AS}=5.4\text{A}$ ,  $L=5\text{mH}$ ,  $V_{GS}=10\text{V}$ ,  $V_{DD}=50\text{V}$ **Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	0.93	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max	$R_{\theta JA}$	62.5	



**Characteristics (Tj=25°C, unless otherwise specified)**

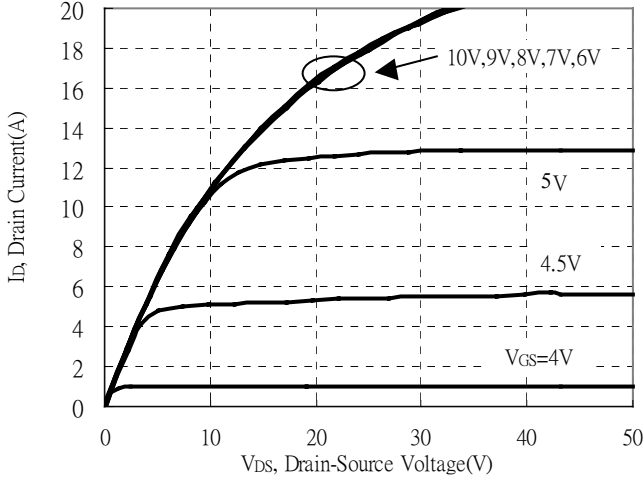
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	500	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	-	0.6	-	V/°C	Reference to 25°C, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	2.0	-	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
*G <sub>FS</sub>	-	8	-	S	V <sub>DS</sub> =15V, I <sub>D</sub> =4A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V
	-	-	25		V <sub>DS</sub> =400V, V <sub>GS</sub> =0V, T <sub>j</sub> =125°C
*R <sub>DS(ON)</sub>	-	0.71	0.9	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A
<b>Dynamic</b>					
*Q <sub>g</sub>	-	26.4	-	nC	I <sub>D</sub> =4.5A, V <sub>DD</sub> =250V, V <sub>GS</sub> =10V
*Q <sub>gs</sub>	-	4.8	-		
*Q <sub>gd</sub>	-	9.9	-		
*t <sub>d(ON)</sub>	-	14	-	ns	V <sub>DD</sub> =250V, I <sub>D</sub> =4.5A, V <sub>GS</sub> =10V, R <sub>G</sub> =1 Ω
*t <sub>r</sub>	-	8.8	-		
*t <sub>d(OFF)</sub>	-	42.6	-		
*t <sub>f</sub>	-	7.8	-		
C <sub>iss</sub>	-	975	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz
C <sub>oss</sub>	-	108	-		
C <sub>rss</sub>	-	76	-		
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	8	A	
*I <sub>SM</sub>	-	-	32		
*V <sub>SD</sub>	-	0.8	1.2	V	I <sub>S</sub> =4.5A, V <sub>GS</sub> =0V
*t <sub>rr</sub>	-	242	-	ns	V <sub>GS</sub> =0V, I <sub>F</sub> =4.5, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	1.5	-	μC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

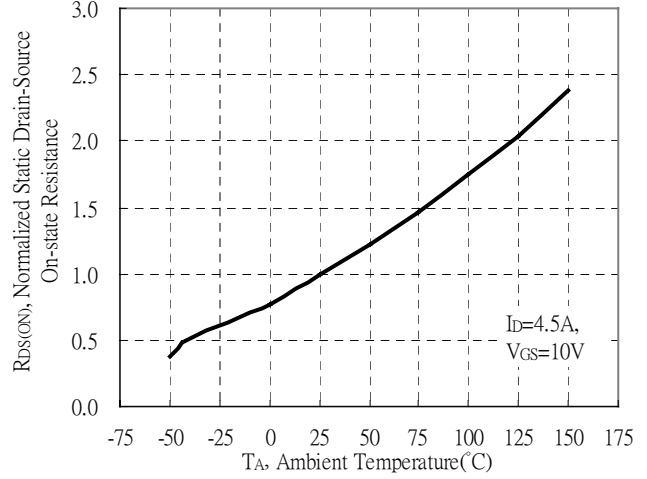


### Typical Characteristics

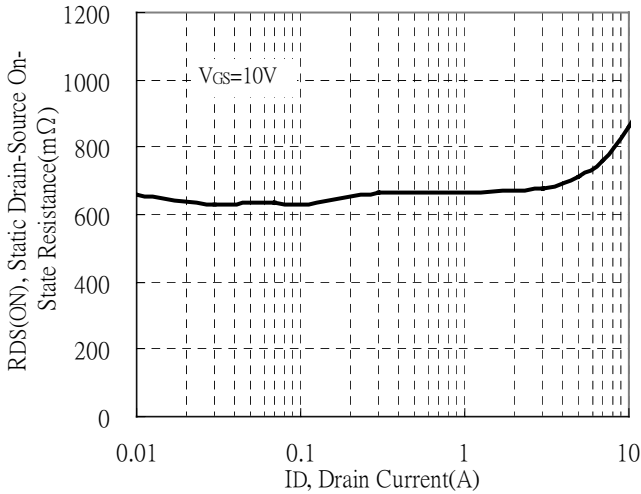
Typical Output Characteristics



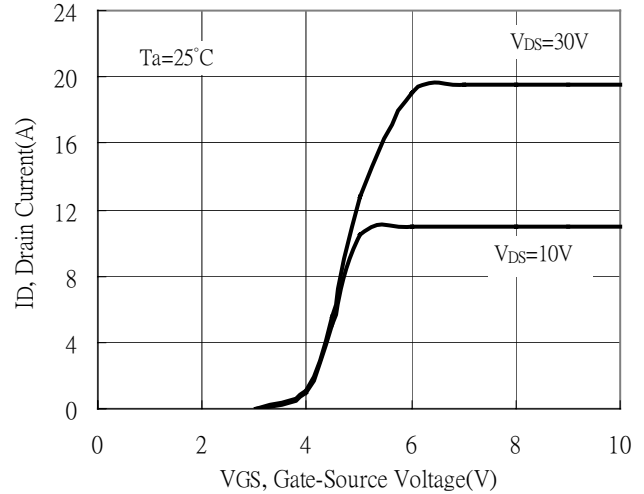
Static Drain-Source On-resistance vs Ambient Temperature



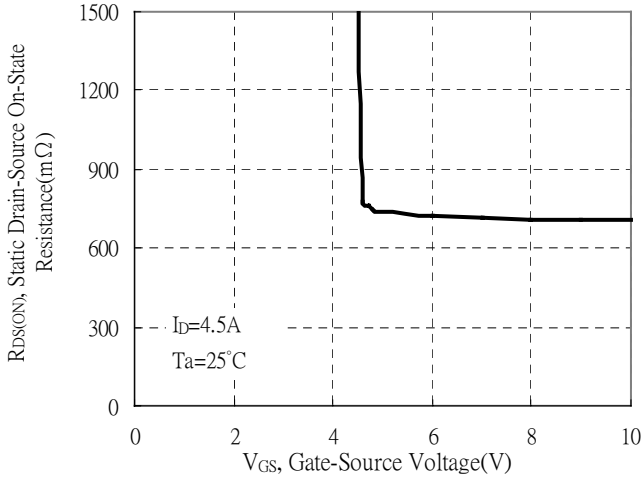
Static Drain-Source On-State resistance vs Drain Current



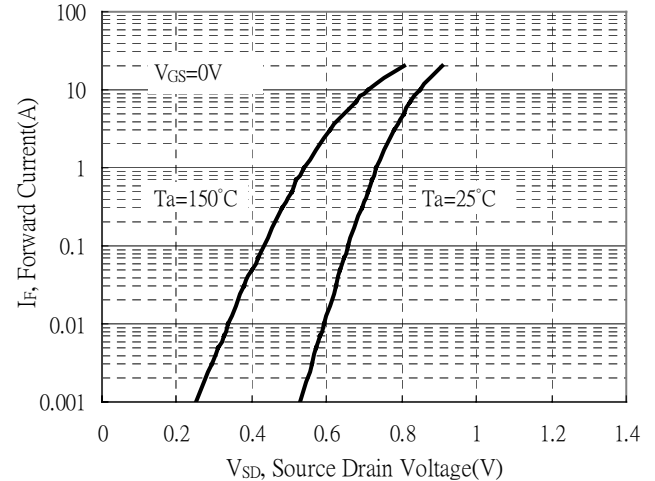
Drain Current vs Gate-Source Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage



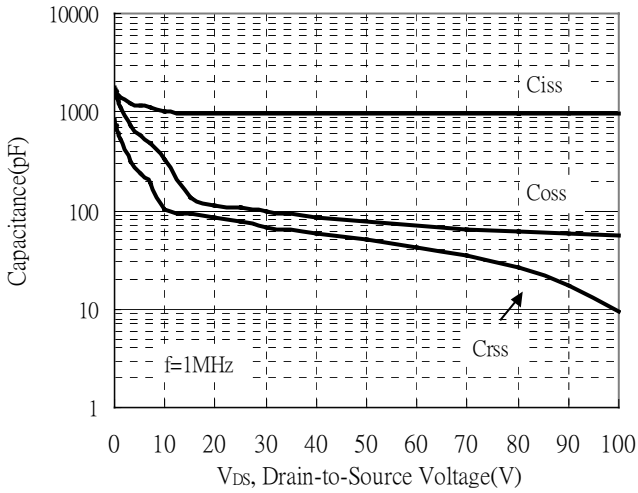
Forward Drain Current vs Source-Drain Voltage



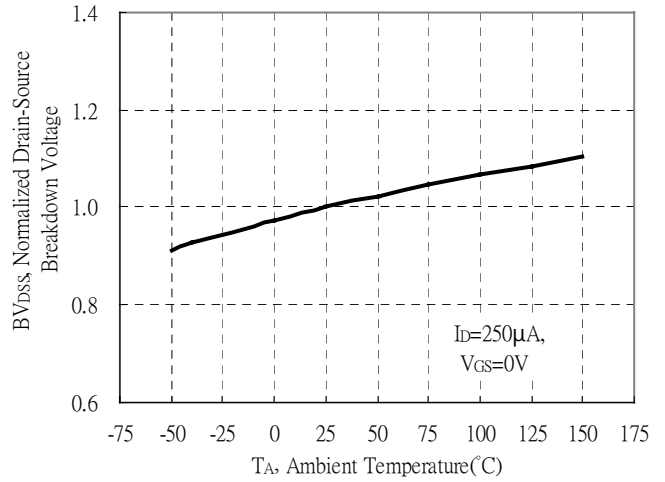


**Typical Characteristics(Cont.)**

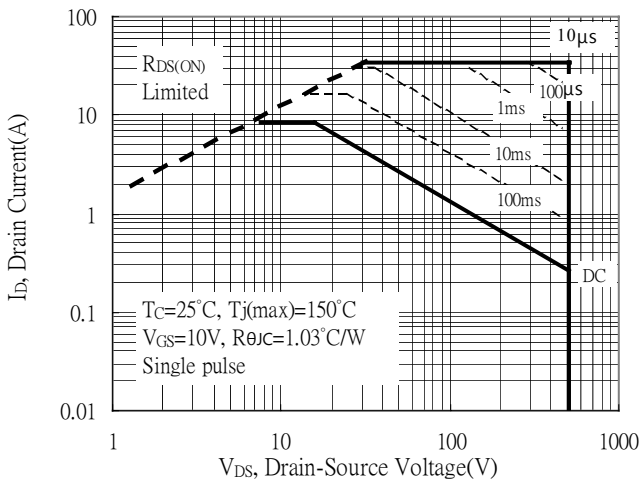
Capacitance vs Reverse Voltage



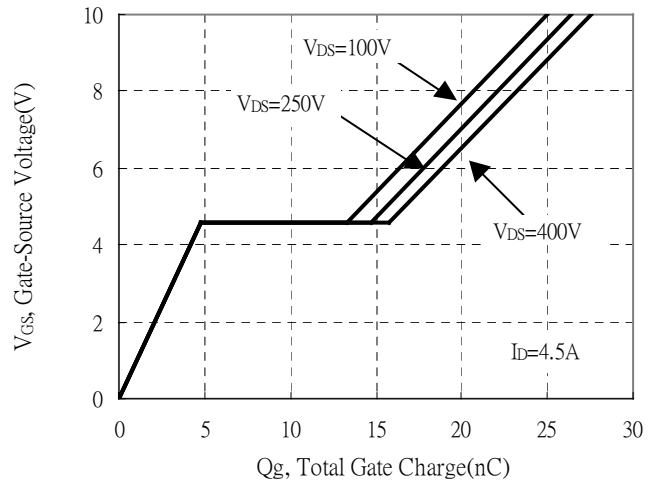
Brekdown Voltage vs Ambient Temperature



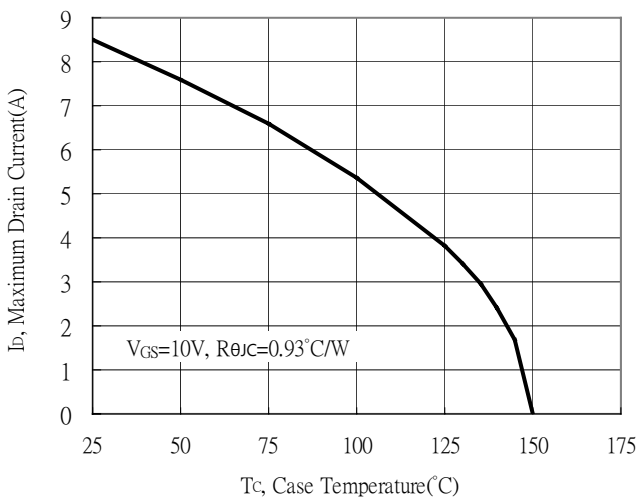
Maximum Safe Operating Area



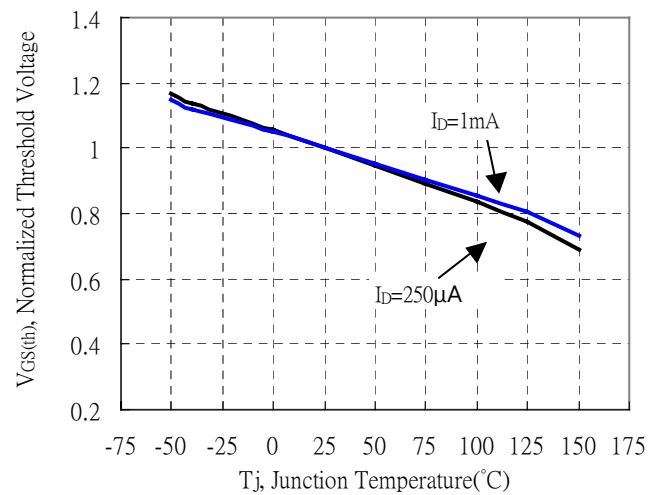
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature



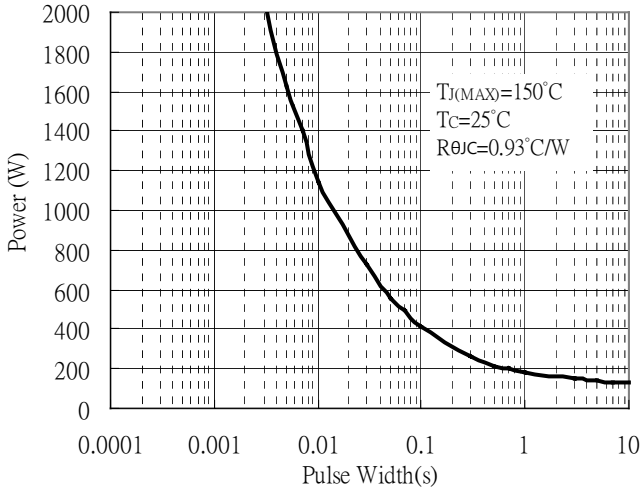
Threshold Voltage vs Junction Temperature



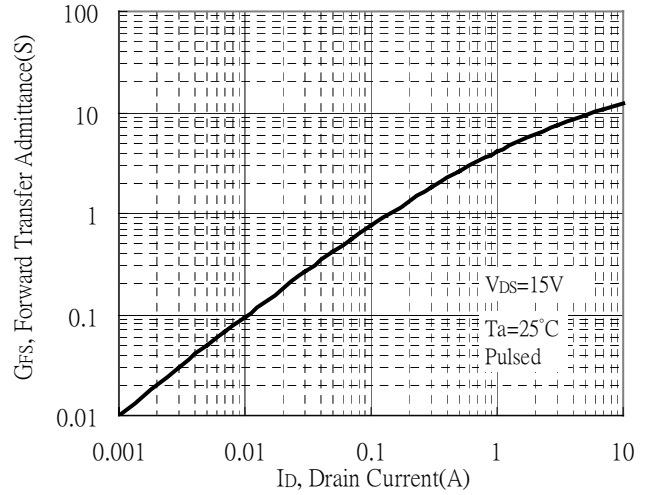


**Typical Characteristics(Cont.)**

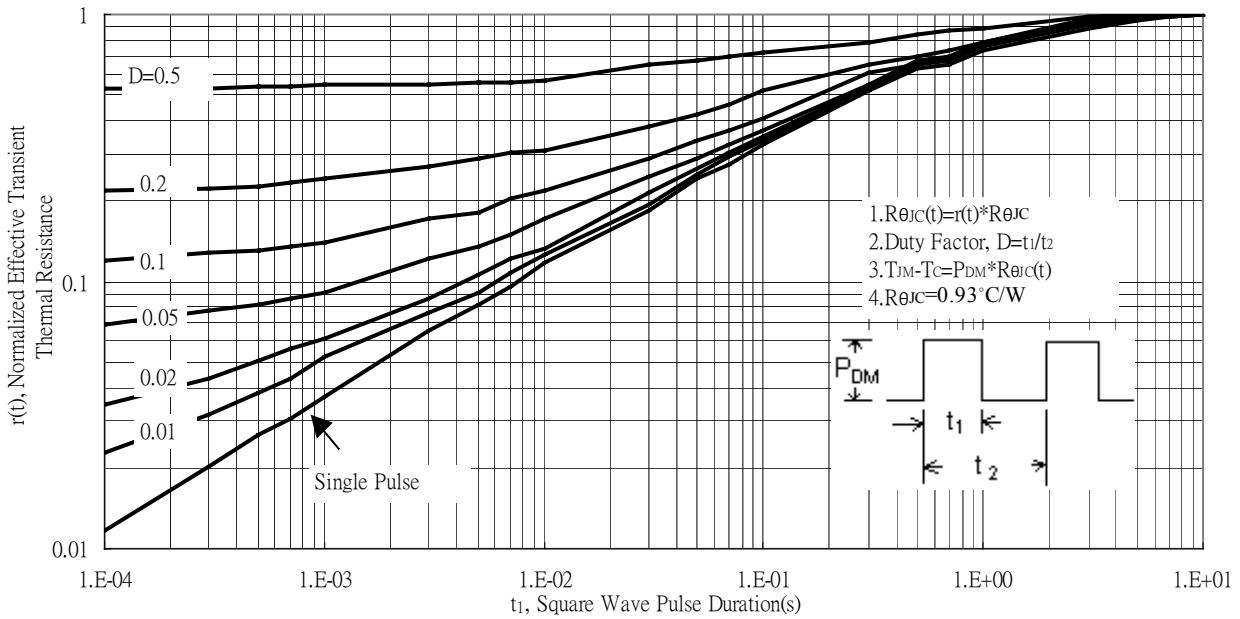
Single Pulse Power Rating, Junction to Case



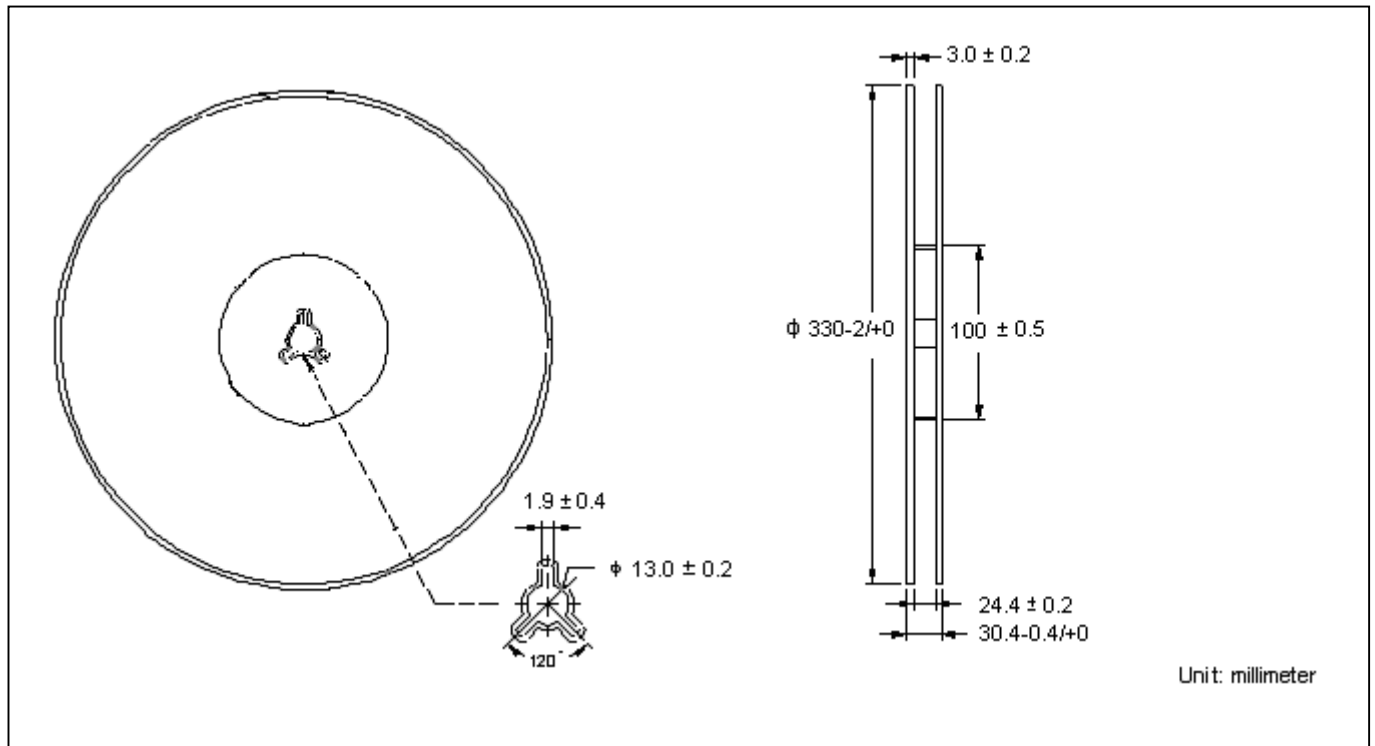
Forward Transfer Admittance vs Drain Current



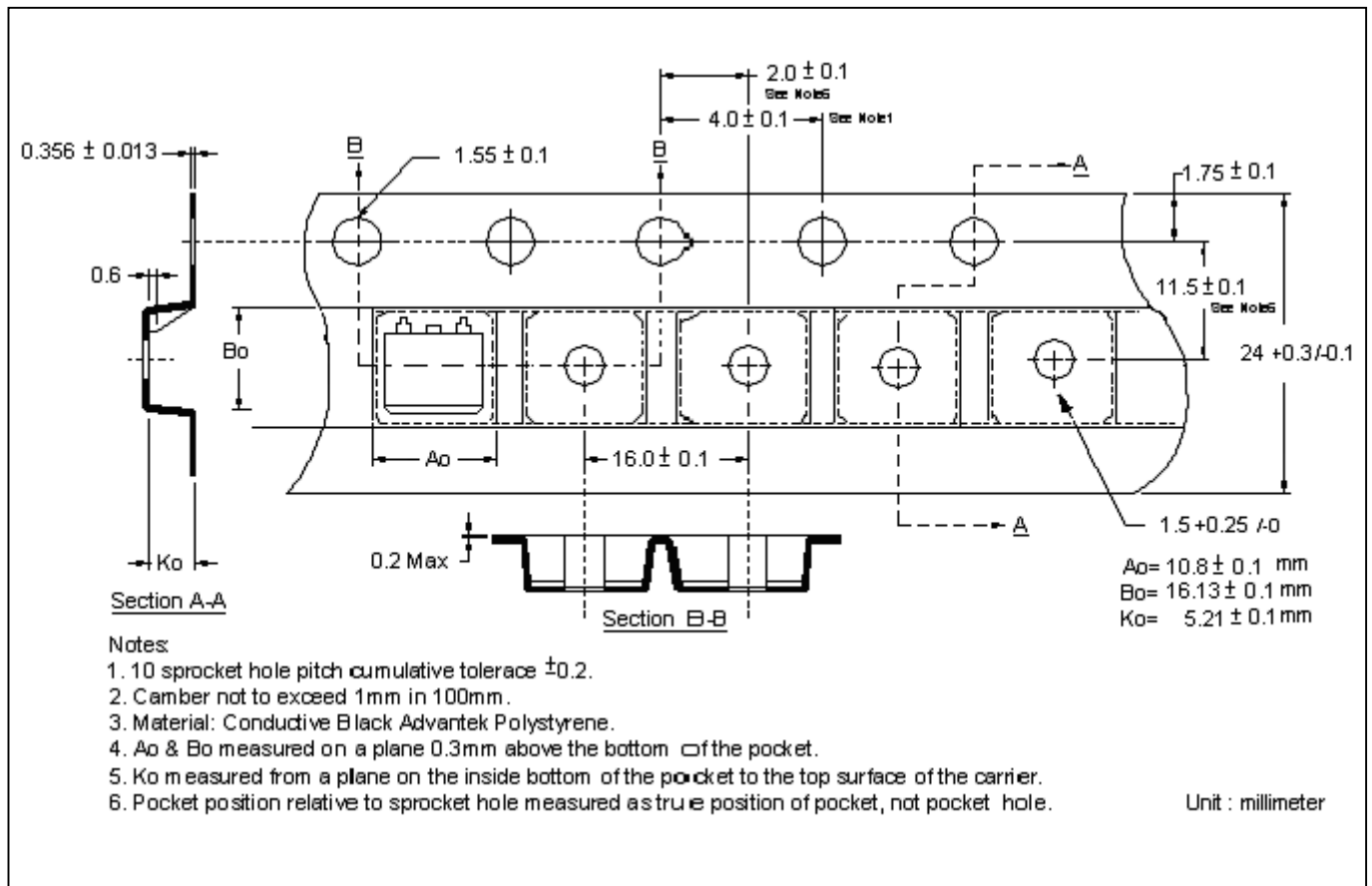
Transient Thermal Response Curves



**Reel Dimension**

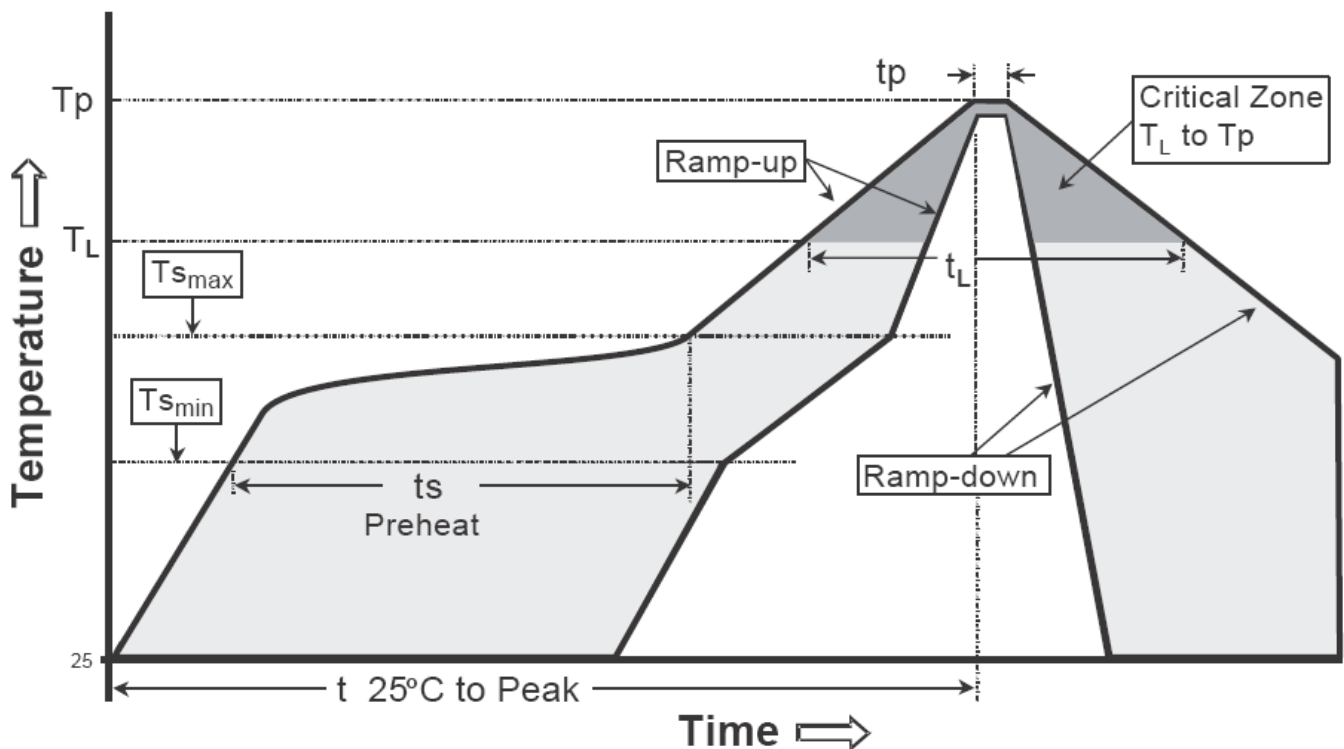


**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

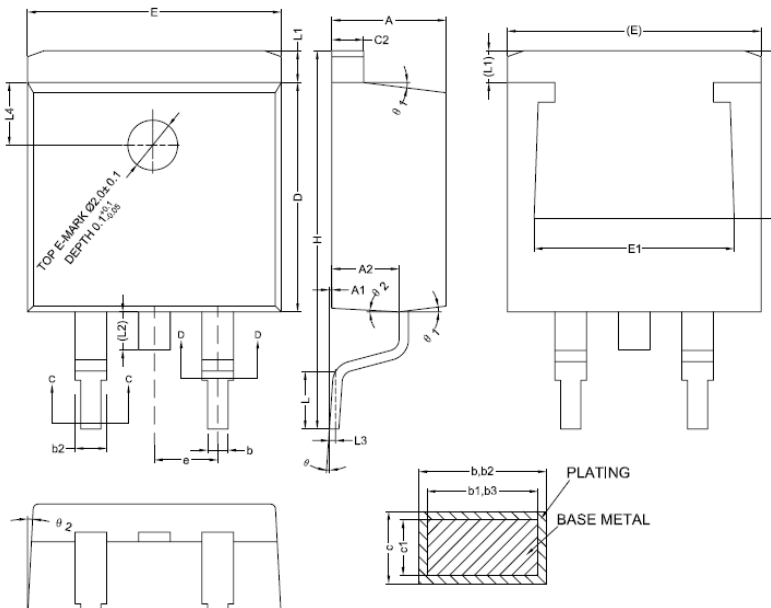
**Recommended temperature profile for IR reflow**


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tl)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

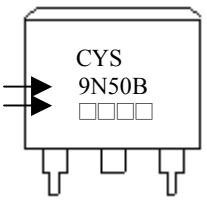
Note : All temperatures refer to topside of the package, measured on the package body surface.



**TO-263 Dimension**



**Marking :**



Device Name → CYS 9N50B  
 Date Code → □□□□

Style : Pin 1.Gate 2.Drain  
3.Source

3-Lead Plastic Surface Mounted Package  
 CYStek Package Code : F3

Date Code : (From left to right)  
 First Code : Year code, the last digit of Christnr year. For example, 2014→4, 2015→, 2016→6, ..., etc.  
 Second Code : Month code, Jan→A, Feb→B, Mar→C, Apr→D, May→E, Jun→F, Jul→G, Aug→H, Sep→J,  
 Oct→K, Nov→L, Dec→M  
 Third and fourth codes : production serial number, 01~99

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	4.40	4.70	0.173	0.185	E	10.06	10.26	0.396	0.404
A1	0.00	0.25	0.000	0.010	E1	7.80	8.20	0.307	0.323
A2	2.59	2.79	0.102	0.110	e	2.54 BSC		0.100 BSC	
b	0.77	0.90	0.030	0.035	H	14.70	15.50	0.579	0.610
b1	0.76	0.86	0.030	0.034	L	2.00	2.60	0.079	0.102
b2	1.23	1.36	0.048	0.054	L1	1.17	1.40	0.046	0.055
b3	1.22	1.32	0.048	0.052	L2	-	1.75	-	0.069
c	0.34	0.47	0.013	0.019	L3	0.25 BSC		0.010 BSC	
c1	0.33	0.43	0.013	0.017	L4	2.00 REF		0.079 BSC	
c2	1.22	1.32	0.048	0.052	θ	0°	8°	0°	8°
D	9.05	9.25	0.356	0.364	θ1	5°	9°	5°	9°
D1	6.60	-	0.260	-	θ2	1°	5°	1°	5°

Notes : 1.Controlling dimension : millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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